Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/644,098	OWAKI ET AL.
Examiner	Art Unit
Lv T. TRAN	2853

	SEAR	CHED	:
Class	Subclass	Date	Examiner
347	20,22,29 104	9/23/2005	LT
		:	

INT	FERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
347	29	10/12/2005	LT
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SE (INCLUDINC	ARCH NOT	ES STRATEGY	)
		DATE	EXMR
text		9/23/2005	